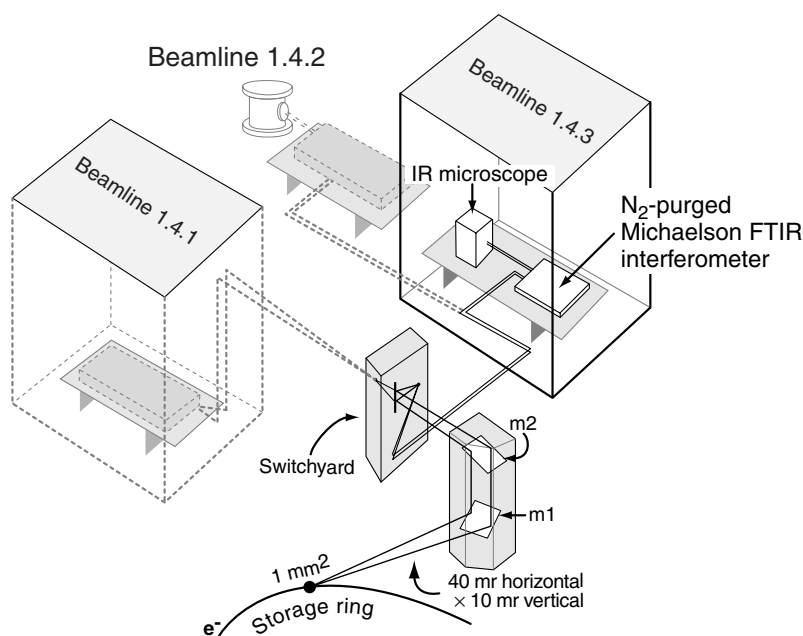


# Infrared Spectromicroscopy (FTIRSM) • Beamline 1.4.3

Berkeley Lab • University of California

## Beamline Specifications

Photon Energy Range (cm <sup>-1</sup> )	Spectral Resolution (cm <sup>-1</sup> )	Spot Size (μm)	Availability
450–10,000 (0.05–1 eV)	0.125	<10 (diffraction limited)	NOW



Schematic layout of Beamline 1.4.3.

**B**eamline 1.4 serves three distinct experimental stations designated as Beamlines 1.4.1, 1.4.2, and 1.4.3. Beamline 1.4.3 provides state-of-the-art Fourier transform infrared (FTIR) spectromicroscopy in the mid-IR region from 10,000 to 450 cm<sup>-1</sup>. All-reflecting optics focus the bend-magnet radiation into a switchyard. The switchyard houses optics that collimate the radiation and distribute it to the three experimental stations.

The synchrotron beam serves as an external source for a Nicolet Magna 760 FTIR bench. The beam, after being modulated by the moving mirror in the Michelson interferometer in the 760, passes

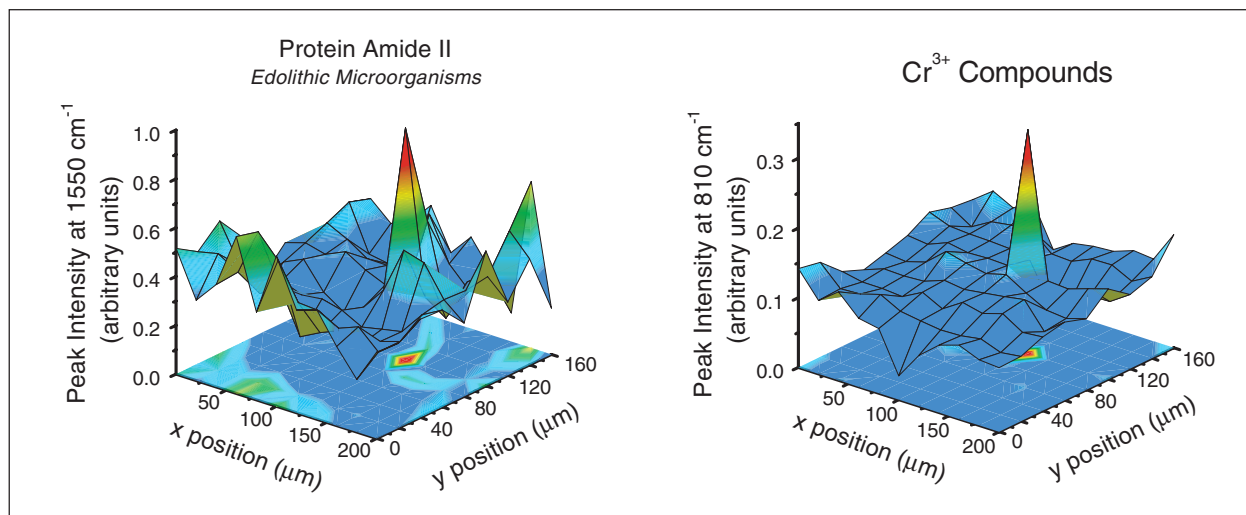
into a Nicolet Nic-Plan IR microscope. The Nic-Plan has two all-reflecting objectives, 15× and 32×, which allow both reflecting and transmitting modes of operation. A grazing-incidence objective and a variable-temperature stage (70–730 K) are available. A computer-controlled, motorized sample stage can obtain spectral maps with 1-μm spatial precision.

Since the synchrotron beam is many times brighter than conventional IR sources, the beam may be focused to small diameters with little loss of signal. With the 32× objective, the full-width, half-maximum (FWHM) spot size, integrated over all mid-IR wavelengths, is less than 10 μm. This spot

size becomes diffraction limited at longer wavelengths. When measuring areas with diameters less than 100  $\mu\text{m}$ , the synchrotron provides substantial improvement in signal over the conventional global source.

Typical experiments are in environmental science (adsorbates, bacteria, soil chemistry, remediation), particulate contamination (defects on silicon

wafers), biological materials (bioremediation, identification of biomolecules, tissue analysis), microscopic films and crystals (novel electronic materials and molecules), polymer laminates and composites (photographic film), forensic studies (drug identification, fiber analysis), and systems at high pressure (materials in diamond anvil cells). Visit [infrared.als.lbl.gov](http://infrared.als.lbl.gov) for more information. ■



**Spatially resolved, time-dependent evidence for biogeochemical transformation of hexavalent chromium ( $\text{Cr}^{6+}$ ),** a widespread industrial contaminant. After a four-month exposure of basalt rock chips to solutions of  $\text{Cr}^{6+}$  and toluene vapor, FTIR spectromicroscopy showed that  $\text{Cr}^{6+}$ -tolerant and  $\text{Cr}^{6+}$ -reducing microorganisms were thriving in association with  $\text{Cr}^{3+}$ . Data courtesy of Hoi-Ying Holman, Dale L. Perry, Michael C. Martin, Wayne R. McKinney (Berkeley Lab), and Jennie C. Hunter-Cevera (University of Maryland).

**This beamline is available to independent investigators by submitting a proposal.**

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#### To Obtain a Proposal Form

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